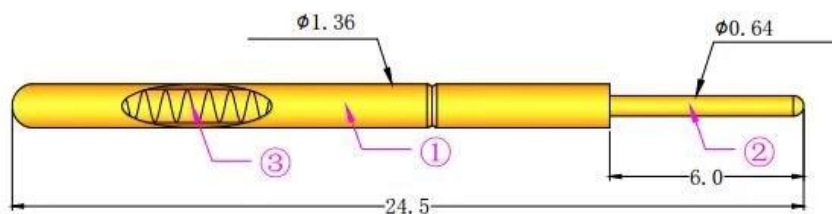


customized test probe pin SF-PA160-J which dia is 0.64mm

Product Picture





Materials (Plated) (材質與鍍層):

- ① Barrel (針套) : Brass (黃銅) , Au on Ni Plated
- ② Plunger (針軸) : BeCu (鈹銅) , Au on Ni Plated
- ③ Spring (彈弓) : SUS304 (不銹鋼線) , /

Specifications (技術要求):

- Current Rating (額定電流) : 3A
- Contact Resistance (接觸電阻) : 50mΩ
- Rated Stroke (額定沖程) : 4.0mm
- Spring Force (額定彈力) : 200+50gf @ Load 4.0mm

Our Service

1. We can reply your inquiry within 24 working hours.
2. Customized design is available and OEM are welcomed.
3. We can deliver the probe pins to our clients all over the world with speed and precision.
4. We can provide the lowest price with high quality product to our client .

Main Products

Spring loaded pin (single) for PCB, ICT, FCT testing etc;

Pogo pin (connector) to establish connection between two printed circuit boards for charging, locating, Battery, Semiconductor & Interconnect applications;

Double ended probe for BGA and Semiconductor testing;







Universal pin without spring, coating pin, LM pin with QZ and VZ series;

High current probe, Switch probe, Capacitance needle;

Terminal & receptacle /socket;

Other related electronic components, 30# OK wire, Jig locks, POM, Iron hinge etc

Quality Control

| | | |
|--|--|---|
| Spring exhausted tester | DC power supply | Current resistance tester |
|  |  |  |
| Microscope | Tensile strength tester | Spring tester |
|  |  |  |

Packing Picture

